

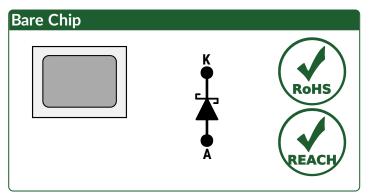
Silicon Carbide Schottky Diode

For physical chip dimensions please contact engineering@diedevices.com

 V_{RRM} = 1200 V $I_{F(T_C = 144^{\circ}C)}$ = 50 A Q_C = 162 nC

Features

- Gen4 Thin Chip Technology for Low V_F
- Superior Figure of Merit Qc*V_F
- Industry-Leading Avalanche (UIL) Robustness
- Enhanced Surge Current Withstand Capability
- Temperature Independent Fast Switching
- Low Thermal Resistance
- Positive Temperature Coefficient of V_F
- High dV/dt Ruggedness



Advantages

- Improved System Efficiency
- High System Reliability
- Optimal Price Performance
- Reduced Cooling Requirements
- Increased System Power Density
- Zero Reverse Recovery Current
- Easy to Parallel without Thermal Runaway
- Enables Extremely Fast Switching

Applications

- Electric Vehicles and Fast Chargers
- Solar Inverters
- Train Auxiliary Power Supplies
- High frequency Converters
- Motor Drives
- Induction Heating and Welding
- Uninterruptible Power Supplies
- Pulsed Power

Absolute Maximum Ratings (At T _C = 25°C Unless Otherwise Stated)					
Parameter	Symbol	Conditions	Values	Unit	Note
Repetitive Peak Reverse Voltage	V_{RRM}		1200	V	
Continuous Forward Current	l _F	$T_C = 100^{\circ}C, D = 1$	86	Α	
		$T_C = 135^{\circ}C, D = 1$	59		Fig. 4
		$T_C = 144^{\circ}C, D = 1$	50		
Non-Repetitive Peak Forward Surge Current, Half Sine Wave	I _{F,} SM	T_C = 25°C, t_P = 10 ms	300	Α	
		T_C = 150°C, t_P = 10 ms	50		
Repetitive Peak Forward Surge Current, Half Sine Wave	I _{F,RM}	T_C = 25°C, t_P = 10 ms	100	Α	
		T_C = 150°C, t_P = 10 ms	50		
Non-Repetitive Peak Forward Surge Current	I _{F,MAX}	T_C = 25°C, t_P = 10 μ s	200	Α	
i ² t Value	∫i²dt	$T_C = 25^{\circ}C$, $t_P = 10 \text{ ms}$	450	A ² s	
Non-Repetitive Avalanche Energy	E _{AS}	L = 0.4 mH, I _{AS} = 50 A	452	mJ	
Diode Ruggedness	dV/dt	V _R = 0 ~ 960 V	200	V/ns	
Power Dissipation	Ртот	T _C = 25°C	463	W	Fig. 3
Operating and Storage Temperature	T_j , T_{stg}		-55 to 175	°C	

Note 1: Assumes Thermal Resistance, Junction - Case (R_{thJC}) of 0.32°C/W





Electrical Characteristics Values Parameter **Symbol Conditions** Unit Note Min. Тур. Max. $I_F = 50 \text{ A}, T_i = 25^{\circ}\text{C}$ 1.8 1.5 ٧ Diode Forward Voltage V_{F} Fig. 1 $I_F = 50 \text{ A}, T_i = 175^{\circ}\text{C}$ 1.9 $V_R = 1200 \text{ V, } T_i = 25^{\circ}\text{C}$ 3 30 **Reverse Current** Fig. 2 I_R μΑ $V_R = 1200 \text{ V}, T_j = 175^{\circ}\text{C}$ 33 $V_R = 400 V$ 111 $\mathbf{Q}_{\mathbf{C}}$ **Total Capacitive Charge** nC Fig. 7 $V_{R} = 800 V$ 162 $I_F \leq I_{F,MAX}$ $dI_F/dt = 200 A/\mu s$ $V_R = 400 V$ Switching Time < 10 ts ns $V_R = 800 V$ 1842 $V_R = 1 V$, f = 1MHzС **Total Capacitance** рF Fig. 6 V_R = 800 V, f = 1MHz 108

Mechanical Parameters

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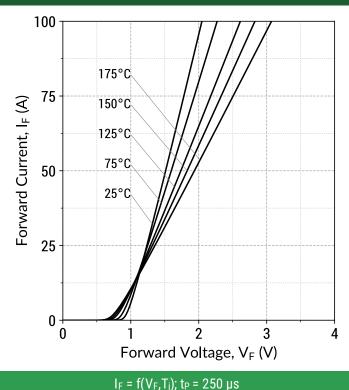


Figure 2: Typical Reverse Characteristics

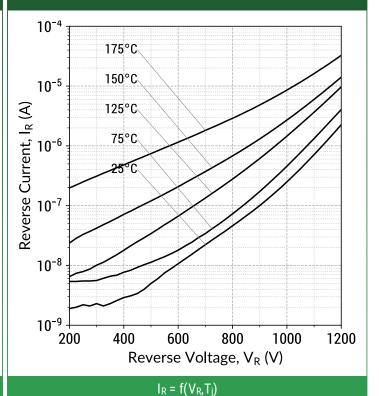


Figure 3: Typical Junction Capacitance vs Reverse Voltage Characteristics

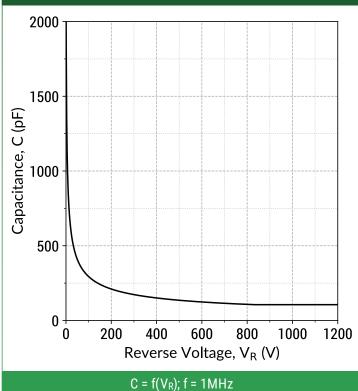


Figure 4: Typical Capacitive Charge vs Reverse Voltage Characteristics

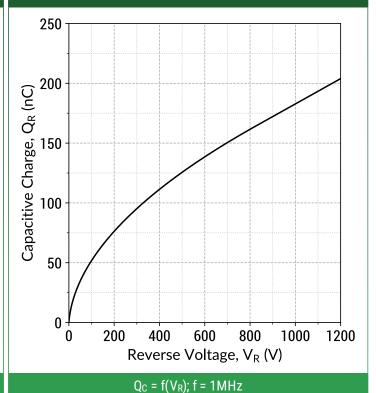
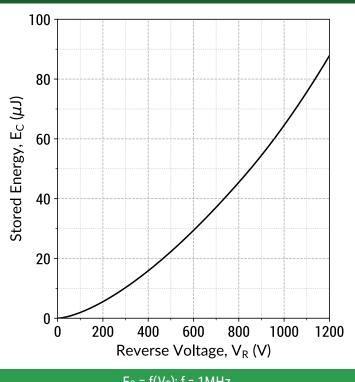


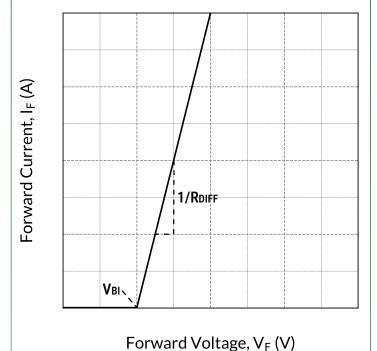


Figure 5: Typical Capacitive Energy vs Reverse Voltage Characteristics



 $E_C = f(V_R)$; f = 1MHz

Figure 6: Forward Curve Model



 $I_F = f(V_F, T_j)$

Forward Curve Model Equation:

 $I_F = (V_F - V_{BI})/R_{DIFF} (A)$

Built-In Voltage (V_{BI}):

 $V_{BI}(T_j) = m \times T_j + n (V)$ $m = -0.00119 (V/^{\circ}C)$ n = 1.01 (V)

Differential Resistance (RDIFF):

 $R_{DIFF}(T_j) = a \times T_j^2 + b \times T_j + c (\Omega)$ $a = 2.37e-07 (\Omega/^{\circ}C^2)$ $b = 3.29e-05 (\Omega/^{\circ}C)$ $c = 0.00976 (\Omega)$

Forward Power Loss Equation:

 $P_{LOSS} = V_{BI}(T_j) \times I_{AVG} + R_{DIFF}(T_j) \times I_{RMS}^2$



Chip Dimensions

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NOTE

- 1. CONTROLLED DIMENSION IS MILLIMETER.
- 2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS.





Compliance

RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS 2), as adopted by EU member states on January 2, 2013 and amended on March 31, 2015 by EU Directive 2015/863. RoHS Declarations for this product can be obtained from your GeneSiC representative.

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Revision History

Rev 21/Jun: Updated with most recent test data

· Supersedes: Rev 20/Jul



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